

SAMPLE

検査成績表  
<TEST REPORT>

品名<Model Name> ( C/ハイテスタ<C HiTESTER> )  
 形名<Model Number> ( 3506 )  
 製造番号<Serial No.> ( No. 121201234 )  
 検査年月日<Test Date> ( 2012-12-20 )  
 <YYYY-MM-DD>  
 検査条件<Test Conditions> ( 23.0 °C, 50 %rh )

項目 <Item>	設定値 <Setup Value>	標準器 <Standard>	許容範囲 <Tolerance>	測定値 *1 <Measured Value>
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測定信号レベル<Measurement Signal Level>

1kHz	500 mV	—	445.00 mV ~ 555.00 mV	( 500.00 mV)
1MHz	500 mV	—	445.00 mV ~ 555.00 mV	( 500.00 mV)
1kHz	1 V	—	0.8950 V ~ 1.1050 V	( 1.0000 V)
1MHz	1 V	—	0.8950 V ~ 1.1050 V	( 1.0000 V)

測定周波数<Measurement Frequency>

1kHz	1 V	—	0.99990 kHz ~ 1.00010 kHz	( 1.00000 kHz)
1MHz	1 V	—	0.99990 MHz ~ 1.00010 MHz	( 1.00000 MHz)

備考<Note>

\*1.FAIL判定箇所は、グレー表示としています。<FAIL decision points are highlighted in gray.>

\*2.標準器校正値を使用しているポイントの許容範囲は、標準器校正値を基準に定めています。

<The tolerance for each point using the standard calibration value is based on the standard calibration value.>

総合判定<Overall Result> ( PASS )	検査者<Inspected By> ( )	承認者<Approved By> ( )
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<TEST REPORT>

製造番号<Serial No.> ( No. 121201234 )  
 検査年月日<Test Date> ( 2012-12-20 )  
 <YYYY-MM-DD>

項目 <Item>	設定値<Setup Value>			標準器 (標準器校正値)		許容範囲 *2			表示値 *1	
<Range>	<Frequency>	<Level>	<Standard> (<Std. Cal. Value>)		<Tolerance>			<Indicated Value>		
精度<Accuracy> 測定スピード*: SLOW、ケーブル: 0m <Speed: SLOW Cable: 0m>										
(Sample: 0.22pF) <G-D>										
220fF	1MHz	1V	C	220fF	( 219.930 fF)	217.291 fF	~	222.569 fF	( 219.890 fF)	
			D		( 0.00115 )	-0.00485	~	0.00715	( 0.00000 )	
(Sample: 0.47pF)										
470fF	1MHz	1V	C	470fF	( 470.010 fF)	467.895 fF	~	472.125 fF	( 470.020 fF)	
			D		( 0.00056 )	-0.00343	~	0.00455	( 0.00000 )	
(Sample: 1pF)										
1pF	1MHz	1V	C	1pF	( 0.99975 pF)	0.99696 pF	~	1.00254 pF	( 0.99975 pF)	
			D		( 0.00032 )	-0.00268	~	0.00332	( 0.00000 )	
2.2pF	1MHz	1V	C	1pF	( 0.99975 pF)	0.99680 pF	~	1.00270 pF	( 0.99975 pF)	
			D		( 0.00032 )	-0.00176	~	0.00240	( 0.00000 )	
4.7pF	1MHz	1V	C	1pF	( 0.99975 pF)	0.99668 pF	~	1.00282 pF	( 0.99975 pF)	
			D		( 0.00032 )	-0.00229	~	0.00293	( 0.00000 )	
(Sample: 10pF)										
周波数シフト<Frequency Shift>										
10pF	1MHz	0%	1V	10pF	( 9.9922 pF)	9.9782 pF	~	10.0061 pF	( 9.9922 pF)	
			D		( 0.00025 )	-0.00125	~	0.00175	( 0.00000 )	
10pF	1MHz	-2%	1V	10pF	( 9.9922 pF)	9.9782 pF	~	10.0061 pF	( 9.9922 pF)	
			D		( 0.00025 )	-0.00125	~	0.00175	( 0.00000 )	
10pF	1MHz	-1%	1V	10pF	( 9.9922 pF)	9.9782 pF	~	10.0061 pF	( 9.9922 pF)	
			D		( 0.00025 )	-0.00125	~	0.00175	( 0.00000 )	
10pF	1MHz	+1%	1V	10pF	( 9.9922 pF)	9.9782 pF	~	10.0061 pF	( 9.9922 pF)	
			D		( 0.00025 )	-0.00125	~	0.00175	( 0.00000 )	
10pF	1MHz	+2%	1V	10pF	( 9.9922 pF)	9.9782 pF	~	10.0061 pF	( 9.9922 pF)	
			D		( 0.00025 )	-0.00125	~	0.00175	( 0.00000 )	
(Sample: 10pF)										
22pF	1MHz	1V	C	10pF	( 9.9922 pF)	9.9758 pF	~	10.0085 pF	( 9.9922 pF)	
			D		( 0.00025 )	-0.00141	~	0.00191	( 0.00000 )	
47pF	1MHz	1V	C	10pF	( 9.9922 pF)	9.9708 pF	~	10.0135 pF	( 9.9922 pF)	
			D		( 0.00025 )	-0.00216	~	0.00266	( 0.00000 )	
(Sample: 100pF)										
100pF	1kHz	1V	C	100pF	( 100.022 pF)	99.702 pF	~	100.342 pF	( 100.022 pF)	
			D		( 0.00006 )	-0.00293	~	0.00305	( 0.00000 )	
100pF	1MHz	1V	C	100pF	( 99.994 pF)	99.855 pF	~	100.133 pF	( 99.994 pF)	
			D		( 0.00024 )	-0.00106	~	0.00154	( 0.00000 )	
220pF	1kHz	1V	C	100pF	( 100.022 pF)	99.726 pF	~	100.318 pF	( 100.022 pF)	
			D		( 0.00006 )	-0.00201	~	0.00213	( 0.00000 )	
220pF	1MHz	1V	C	100pF	( 99.994 pF)	99.831 pF	~	100.157 pF	( 99.994 pF)	
			D		( 0.00024 )	-0.00142	~	0.00190	( 0.00000 )	

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<TEST REPORT>

製造番号<Serial No.> ( No. 121201234 )  
 検査年月日<Test Date> ( 2012-12-20 )  
 <YYYY-MM-DD>

項目 <Item>	設定値<Setup Value>			標準器 (標準器校正値)		許容範囲 *2			表示値 *1
<Range>	<Frequency>	<Level>	<Standard>	<Std. Cal. Value>	<Tolerance>			<Indicated Value>	
確度<Accuracy> 測定スピード: SLOW、ケーブル: 0m <Speed: SLOW Cable: 0m>									
(Sample: 100pF)									
470pF	1kHz	1V	C	100pF	( 100.022 pF )	99.714 pF	~	100.330 pF	( 100.022 pF )
			D		( 0.00006 )	-0.00254	~	0.00266	( 0.00000 )
470pF	1MHz	1V	C	100pF	( 99.994 pF )	99.781 pF	~	100.207 pF	( 99.994 pF )
			D		( 0.00024 )	-0.00217	~	0.00265	( 0.00000 )
(Sample: 1nF)									
1nF	1kHz	1V	C	1nF	( 1.00072 nF )	0.99932 nF	~	1.00212 nF	( 1.00072 nF )
			D		( 0.00003 )	-0.00146	~	0.00152	( 0.00000 )
1nF	1MHz	1V	C	1nF	( 1.00101 nF )	0.99961 nF	~	1.00241 nF	( 1.00101 nF )
			D		( 0.00019 )	-0.00110	~	0.00148	( 0.00000 )
2.2nF	1kHz	1V	C	1nF	( 1.00072 nF )	0.99908 nF	~	1.00236 nF	( 1.00072 nF )
			D		( 0.00003 )	-0.00182	~	0.00188	( 0.00000 )
4.7nF	1kHz	1V	C	1nF	( 1.00072 nF )	0.99858 nF	~	1.00286 nF	( 1.00072 nF )
			D		( 0.00003 )	-0.00237	~	0.00243	( 0.00000 )
(Sample: 10nF) <C-D>									
10nF	1kHz	1V	C	10nF	( 10.0007 nF )	9.9867 nF	~	10.0147 nF	( 10.0007 nF )
			D		( 0.00000 )	-0.00129	~	0.00129	( 0.00000 )
22nF	1kHz	1V	C	10nF	( 10.0007 nF )	9.9843 nF	~	10.0171 nF	( 10.0007 nF )
			D		( 0.00000 )	-0.00165	~	0.00165	( 0.00000 )
47nF	1kHz	1V	C	10nF	( 10.0007 nF )	9.9793 nF	~	10.0221 nF	( 10.0007 nF )
			D		( 0.00000 )	-0.00240	~	0.00240	( 0.00000 )
(Sample: 100nF)									
100nF	1kHz	1V	C	100nF	( 100.000 nF )	99.860 nF	~	100.139 nF	( 100.000 nF )
			D		( 0.00005 )	-0.00125	~	0.00135	( 0.00000 )
220nF	1kHz	1V	C	100nF	( 100.000 nF )	99.836 nF	~	100.163 nF	( 100.000 nF )
			D		( 0.00005 )	-0.00161	~	0.00171	( 0.00000 )
470nF	1kHz	1V	C	100nF	( 100.000 nF )	99.786 nF	~	100.213 nF	( 100.000 nF )
			D		( 0.00005 )	-0.00236	~	0.00246	( 0.00000 )
(Sample: 1μF)									
1μF	1kHz	1V	C	1μF	( 0.99997 μF )	0.99858 μF	~	1.00136 μF	( 0.99997 μF )
			D		( 0.00005 )	-0.00125	~	0.00135	( 0.00000 )
2.2μF	1kHz	1V	C	1μF	( 0.99997 μF )	0.99834 μF	~	1.00160 μF	( 0.99997 μF )
			D		( 0.00005 )	-0.00161	~	0.00171	( 0.00000 )
4.7μF	1kHz	1V	C	1μF	( 0.99997 μF )	0.99784 μF	~	1.00210 μF	( 0.99997 μF )
			D		( 0.00005 )	-0.00236	~	0.00246	( 0.00000 )
(Sample: 10μF)									
10μF	1kHz	1V	C	10μF	( 9.9989 μF )	9.9850 μF	~	10.0128 μF	( 9.9993 μF )
			D		( 0.00021 )	-0.00109	~	0.00151	( 0.00000 )

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 <YYYY-MM-DD>

項目 <Item>	設定値<Setup Value>			標準器 (標準器校正值)		許容範囲 *2			表示値 *1	
	<Range>	<Frequency>	<Level>	<Standard>	<Std. Cal. Value>	<Tolerance>			<Indicated Value>	

確度<Accuracy> 測定スピード: SLOW、ケーブル: 1m <Speed: SLOW Cable: 1m>

(Sample: 10pF)				<C-D>						
10pF	1MHz	1V	C	10pF	( 9.9922 pF )	9.9712 pF	~	10.0131 pF	( 9.9922 pF )	
			D		( 0.00025 )	-0.00200	~	0.00250	( 0.00000 )	
(Sample: 100pF)										
100pF	1MHz	1V	C	100pF	( 99.994 pF )	99.785 pF	~	100.203 pF	( 99.994 pF )	
			D		( 0.00024 )	-0.00171	~	0.00219	( 0.00000 )	
(Sample: 10nF)										
10nF	1kHz	1V	C	10nF	( 10.0007 nF )	9.9797 nF	~	10.0217 nF	( 10.0007 nF )	
			D		( 0.00000 )	-0.00194	~	0.00194	( 0.00000 )	
(Sample: 100nF)										
100nF	1kHz	1V	C	100nF	( 100.000 nF )	99.790 nF	~	100.209 nF	( 100.000 nF )	
			D		( 0.00005 )	-0.00190	~	0.00200	( 0.00000 )	

確度<Accuracy> 測定スピード: SLOW、ケーブル: 2m <Speed: SLOW Cable: 2m>

(Sample: 10pF)										
10pF	1MHz	1V	C	10pF	( 9.9922 pF )	9.9642 pF	~	10.0201 pF	( 9.9922 pF )	
			D		( 0.00025 )	-0.00275	~	0.00325	( 0.00000 )	
(Sample: 100pF)										
100pF	1MHz	1V	C	100pF	( 99.994 pF )	99.715 pF	~	100.273 pF	( 99.994 pF )	
			D		( 0.00024 )	-0.00236	~	0.00284	( 0.00000 )	
(Sample: 10nF)										
10nF	1kHz	1V	C	10nF	( 10.0007 nF )	9.9727 nF	~	10.0287 nF	( 10.0007 nF )	
			D		( 0.00000 )	-0.00259	~	0.00259	( 0.00000 )	
(Sample: 100nF)										
100nF	1kHz	1V	C	100nF	( 100.000 nF )	99.720 nF	~	100.279 nF	( 100.000 nF )	
			D		( 0.00005 )	-0.00255	~	0.00265	( 0.00000 )	